

LTE3401H SiGe:C low-noise amplifier MMIC with bypass switch for LTE Rev. 3 – 28 June 2019 Product data sheet

1 General description

The LTE3401H is a high-gain Low-Noise Amplifier (LNA) with bypass switch for LTE receiver applications, available in a small plastic 6-pin thin leadless package.

The LTE3401H delivers system-optimized gain for both primary and diversity applications where sensitivity improvement is required. The high linearity of this low noise device ensures the required receive sensitivity independent of cellular transmit power level in frequency division duplex (FDD) systems. When receive signal strength is sufficient, the LTE3401H can be switched off to operate in bypass mode at increased IP3_i level and a 1 μ A supply current, to lower power consumption. The LTE3401H is internally AC coupled and requires only one external matching inductor.

The LTE3401H is optimized for 1710 MHz to 2690 MHz, but supports 1452 MHz - 1710 MHz as well.

2 Features and benefits

- Operating frequency from 1452 MHz to 2690 MHz
- Noise figure = 0.65 dB
- Gain 19.5 dB
- High input 1 dB compression point of -10.5 dBm
- High in band IP3_i of +2 dBm
- Bypass switch insertion loss of 2.7 dB
- Supply voltage 1.5 V to 3.1 V
- Integrated RF supply decoupling capacitor
- Optimized performance at a supply current of 13.4 mA
- Bypass mode current consumption < 1 μA
- Integrated temperature stabilized bias for easy design
- Requires only one input matching inductor
- Input and Output AC coupled through DC blocking capacitors
- Integrated matching for the output
- · ESD protection on all pins
- Low bill of materials (BOM)
- 6 pins leadless package: 1.1 mm x 0.7 mm x 0.37 mm: 0.40 mm pitch
- 180 GHz transit frequency SiGe:C technology
- Moisture sensitivity Level 1



3 Applications

- LNA for LTE reception in smart phones
- feature phones
- tablet PCs
- RF front-end modules

4 Quick reference data

Table 1. Quick reference data

f = 2140 MHz; V_{CC} = 2.8 V; V_{I(CTRL)} > 0.8 V; T_{amb} = 25 °C. Input matched to 50 Ω using application diagram from Figure 3 and component values as in Table 10. Unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I _{CC}	supply current	in gain mode		-	13.4	16.8	mA
		in bypass mode		-	-	1	μA
G _p	power gain	in gain mode		-	19.5	-	dB
		in bypass mode		-	-2.7	-	dB
NF	noise figure		[1]	-	0.65	-	dB
P _{i(1 dB)}	input power at 1 dB gain compression			-	-10.5	-	dBm
IP3 _i	input third-order intercept point	Δf = 1 MHz		-	+2.0	-	dBm

[1] PCB losses are subtracted.

5 Ordering information

Table 2. Ordering information

	V			
number p	Orderable	Package		
number	part number	Name	Description	Version
LTE3401H	LTE3401HX	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body 1.1 x 0.7 x 0.37 mm	SOT1232

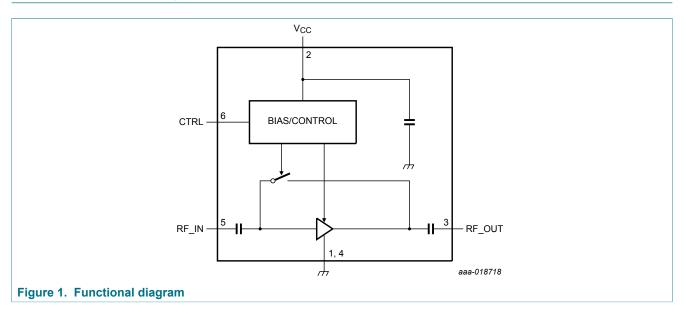
6 Marking

Table 3. Marking code	
Type number	Marking code
LTE3401H	W

LTE3401H

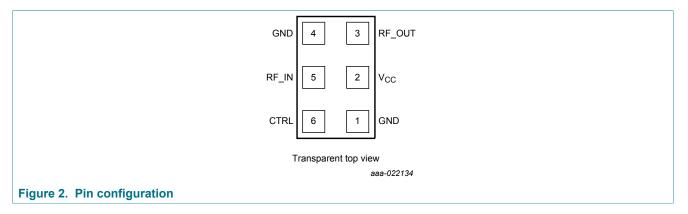
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7 Functional diagram



8 Pinning information

8.1 Pinning



8.2 Pin description

Table 4. Pinning		
Symbol	Pin	Description
GND	1	RF ground
V _{CC}	2	supply voltage
RF_OUT	3	RF out
GND	4	RF ground
RF_IN	5	RF in
CTRL	6	gain control, switch between gain and bypass mode

Limiting values 9

Table 5. Limiting values

In accordance with the absolute maximum rating system (IEC 60134). See section 18.3 "Disclaimers", paragraph "Limiting values".

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage			-0.5	+5.0	V
V _{I(CTRL)}	input voltage on pin CTRL	$V_{I(CTRL)} < V_{CC} + 0.6 V$		-0.5	+5.0	V
V _{I(RF_IN)}	input voltage on pin RF_IN	DC	[1]	-0.5	+0.6	V
V _{I(RF_OUT)}	input voltage on pin RF_OUT	DC, $V_{I(RF_OUT)} < V_{CC} + 0.6 V$	[1]	-0.5	+5.0	V
Pi	input power	RF		-	26	dBm
		RF	[2]	-	23	dBm
Po	output power	RF gain mode, at V_{CC} = 1.8 V		-	12	dBm
		RF bypass mode, at V_{CC} = 1.8 V		-	10	dBm
T _{stg}	storage temperature			-65	+150	°C
Tj	junction temperature			-	150	°C
V _{ESD}	electrostatic discharge voltage	human body model (HBM) according to ANSI/ ESDA/JEDEC standard JS-001	[3]	-	±2	kV
		charged device model (CDM) according to ANSI/ESDA/JEDEC standard JS-002		-	±1	kV

The RF input and output are AC coupled through internal DC Blocking capacitors. f = 2140 MHz; 200 Hrs at T_{amb} = 100 °C. HBM ESD protection level is according to JS-001 classification 2 (2000 V to < 4000 V).

[1] [2] [3]

10 Operating conditions

Table 6.	Operating conditions					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		1.5	-	3.1	V
T _{amb}	ambient temperature		-40	25	85	°C
V _{I(CTRL)}	input voltage on pin CTRL	bypass mode	-	-	0.25	V
		gain mode	0.8	-	-	V

11 Thermal characteristics

Table 7.	Thermal characteristics			
Symbol	Parameter	Conditions	Тур	Unit
R _{th(j-sp)}	junction to solder point thermal resistance		225	K/W

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12 Characteristics

Table 8. Characteristics

1452 MHz \leq f \leq 2690 MHz; V_{CC} =1.8 V; T_{amb} = 25 °C; input matched 50 Ω using application diagram from Figure 3 and component values as in Table 10. Unless otherwise specified.

Symbol	Parameter	Conditions	N	lin	Тур	Мах	Unit
Gain mode	e specifications by frequency point	t				_	
I _{CC}	supply current	V _{I(CTRL)} > 0.8 V	-		12.7	15.8	mA
G _p	power gain	f = 1452 MHz	-		21.0	-	dB
		f = 1710 MHz	-		20.5	-	dB
		f = 2140 MHz	-		19.0	-	dB
		f = 2690 MHz	-		17.0	-	dB
ΔG _p	power gain variation	using input matching inductor 2.7	nH				
		f = 1800 MHz - 2690 MHz	[1] -		+/-2.25	-	dB
		f = 1800 MHz - 2200 MHz	[1] _		+/-1.75	-	dB
		f = 2300 MHz - 2690 MHz	[1] -		+/-1.75	-	dB
ΔG/ΔT	gain variation with temperature		-		-0.015	-	dB/°C
NF	noise figure	f = 1452 MHz	[2] _		0.55	-	dB
		f = 1710 MHz	[2] _		0.55	-	dB
		f = 2140 MHz	[2] _		0.65	-	dB
		f = 2690 MHz	[2] -		0.75	-	dB
P _{i(1dB)}	input power at 1 dB gain	f = 1452 MHz	-		-16.5	-	dBm
	compression	f = 1710 MHz	-		-15.5	-	dBm
		f = 2140 MHz	-		-13.5	-	dBm
		f = 2690 MHz	-		-10.5	-	dBm
IP3 _i	input third-order intercept point	f = 1452 MHz, Δf = 1 MHz	-		-5	-	dBm
		f = 1710 MHz, Δf = 1 MHz	-		-2	-	dBm
		f = 2140 MHz, Δf = 1 MHz	-		0	-	dBm
		f = 2690 MHz, Δf = 1 MHz	-		+2.5	-	dBm
RL _{in}	input return loss	f = 1452 MHz	-		8	-	dB
		f = 1710 MHz	-		8	-	dB
		f = 2140 MHz	-		10	-	dB
		f = 2690 MHz	-		12	-	dB

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Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
RL _{out}	output return loss	f = 1452 MHz	-	10	-	dB
		f = 1710 MHz	-	10	-	dB
		f = 2140 MHz	-	14	-	dB
		f = 2690 MHz	-	9	-	dB
ISL	isolation	f = 1452 MHz	-	34	-	dB
		f = 1710 MHz	-	32	-	dB
		f = 2140 MHz	-	30	-	dB
		f = 2690 MHz	-	30	-	dB
к	Rollett stability factor		1	-	-	
t _{on}	turn-on time	time from V _{I(CTRL)} ON, to 90 % of the gain	-	-	1	μs
t _{off}	turn-off time	time from V _{I(CTRL)} OFF, to 10 % of the gain	-	-	1	μs
Bypass m	ode specifications by frequen	cy point				
I _{CC}	supply current	V _{I(CTRL)} < 0.25 V	-	-	1.0	μA
G _p	power gain	f = 1452 MHz	-	-1.8	-	dB
		f = 1710 MHz	-	-2.5	-	dB
		f = 2140 MHz	-	-2.7	-	dB
		f = 2690 MHz	-	-3.0	-	dB
RL _{in}	input return loss	f = 1452 MHz	-	15	-	dB
		f = 1710 MHz	-	12	-	dB
		f = 2140 MHz	-	13	-	dB
		f = 2690 MHz	-	12	-	dB
RL _{out}	output return loss	f = 1452 MHz	-	14	-	dB
		f = 1710 MHz	-	8	-	dB
		f = 2140 MHz	-	10	-	dB
		f = 2690 MHz	-	15	-	dB
Gain mode	e specifications for wideband	frequency range				
G _p	power gain	f = 1800 MHz - 2690 MHz	^[1] 14.7	18	21.7	dB
		f = 1800 MHz - 2200 MHz	^[1] 16.7	18	21.7	dB
		f = 2300 MHz - 2690 MHz	^[1] 14.7	18	20.5	dB
NF	noise figure	f = 1800 MHz - 2690 MHz	[1] _	0.8	1.3	dB
		f = 1800 MHz - 2200 MHz	[1] _	0.8	1.3	dB
		f = 2300 MHz - 2690 MHz	[1] _	0.8	1.3	dB

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Symbol	Parameter	Conditions	I	Min	Тур	Max	Unit
P _{i(1dB)}	input power at 1 dB gain	f = 1800 MHz - 2690 MHz	1] .	-18	-13	-	dBm
	compression	f = 1800 MHz - 2200 MHz	1]	-17	-12	-	dBm
		f = 2300 MHz - 2690 MHz	1] .	-18	-13	-	dBm
IP3 _i	input third-order intercept point	f = 1800 MHz - 2690 MHz	1] .	-5	0	-	dBm
		f = 1800 MHz - 2200 MHz	1]	-5	0	-	dBm
		f = 2300 MHz - 2690 MHz	1] .	-2	3	-	dBm
VSWR _i	input voltage standing wave ratio	f = 1800 MHz - 2690 MHz	1]	-	-	4	-
VSWR _o	output voltage standing wave ratio	f = 1800 MHz - 2690 MHz	1]	-	-	4	-
ISL	isolation	f = 1800 MHz - 2690 MHz	1]	25	-	-	dB
Δφ	phase variation	f = 1800 MHz - 2690 MHz	1]	-8	-	+8	deg

Guaranteed by device design; not tested in production. PCB losses are subtracted.

[1] [2]

Table 9. Characteristics

1452 MHz \leq f \leq 2690 MHz; V_{CC} = 2.8 V; T_{amb} = 25 °C; input matched 50 Ω using application diagram from Figure 3 and component values as in Table 10. Unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Gain mod	e specifications by frequency point	· · · · · · · · · · · · · · · · · · ·		_	1	_
I _{CC}	supply current	V _{I(CTRL)} > 0.8 V	-	13.4	16.8	mA
G _p	power gain	f = 1452 MHz	-	21.5	-	dB
		f = 1710 MHz	-	21.0	-	dB
		f = 2140 MHz	-	19.5	-	dB
		f = 2690 MHz	-	17.5	-	dB
ΔG/ΔT	gain variation with temperature		-	-0.015	-	dB/°C
NF	noise figure	f = 1452 MHz ^[1]	-	0.55	-	dB
		f = 1710 MHz ^[1]	-	0.55	-	dB
		f = 2140 MHz ^[1]	-	0.65	-	dB
		f = 2690 MHz [1]	-	0.75	-	dB
P _{i(1dB)}	input power at 1 dB gain	f = 1452 MHz	-	-13.5	-	dBm
	compression	f = 1710 MHz	-	-12.5	-	dBm
		f = 2140 MHz	-	-10.5	-	dBm
		f = 2690 MHz	-	-7.5	-	dBm
IP3 _i	input third-order intercept point	f = 1452 MHz, Δf = 1 MHz	-	-3	-	dBm
		f = 1710 MHz, Δf = 1 MHz	-	0	-	dBm
		f = 2140 MHz, ∆f = 1 MHz	-	2	-	dBm
		f = 2690 MHz, ∆f = 1 MHz	-	4.5	-	dBm
RL _{in}	input return loss	f = 1452 MHz	-	9	-	dB
		f = 1710 MHz	-	9	-	dB
		f = 2140 MHz	-	11	-	dB
		f = 2690 MHz	-	12	-	dB
RL _{out}	output return loss	f = 1452 MHz	-	10	-	dB
		f = 1710 MHz	-	10	-	dB
		f = 2140 MHz	-	14	-	dB
		f = 2690 MHz	-	9	-	dB
ISL	isolation	f = 1452 MHz	-	34	-	dB
		f = 1710 MHz	-	32	-	dB
		f = 2140 MHz	-	30	-	dB
		f = 2690 MHz	-	30	-	dB
К	Rollett stability factor		1	-	-	

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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
t _{on}	turn-on time	time from V _{I(CTRL)} ON, to 90 % of the gain	-	-	1	μs
t _{off}	turn-off time	time from V _{I(CTRL)} OFF, to 10 % of the gain	-	-	1	μs
Bypass m	ode specifications by frequer	ncy point				
I _{CC}	supply current	V _{I(CTRL)} < 0.25 V	-	-	1.0	μA
G _p	power gain	f = 1452 MHz	-	-1.8	-	dB
		f = 1710 MHz	-	-2.5	-	dB
		f = 2140 MHz	-	-2.7	-	dB
		f = 2690 MHz	-	-3.0	-	dB
RL _{in}	input return loss	f = 1452 MHz	-	15	-	dB
		f = 1710 MHz	-	12	-	dB
		f = 2140 MHz	-	13	-	dB
		f = 2690 MHz	-	12	-	dB
RL _{out}	output return loss	f = 1452 MHz	-	14	-	dB
		f = 1710 MHz	-	8	-	dB
		f = 2140 MHz	-	10	-	dB
		f = 2690 MHz	-	15	-	dB

[1] PCB losses are subtracted.

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13 Application information

13.1 LTE LNA

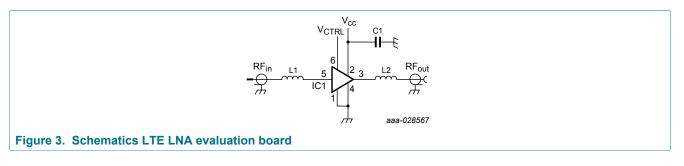


Table 10. List of components

For schematics, see Figure 3.

Component	Description	Value	Remarks
C ₁	decoupling capacitor	1 μF	The total capacitance on the V _{CC} node must be at least 1 μ F. It must be positioned at a short distance from the V _{CC} pin (preferably within 15 mm). Typically, such capacitance is already present at the output of the V _{CC} voltage regulator.
IC1	LTE3401H		NXP
L1	high-quality matching inductor	8.2 nH	1452 - 1560 MHz Murata LQW15A
		5.6 nH	1710 - 1800 MHz Murata LQW15A
		4.3 nH	1800 - 2200 MHz Murata LQW15A
		2.7 nH	1770 - 2690 MHz Murata LQW15A
		2.2 nH	2300 - 2690 MHz Murata LQW15A
L2	output matching inductor	4.7 nH	1452-1560 MHz Murata LQG10A
		no mount	1710-1800 MHz
		no mount	1800-2200 MHz
		no mount	1770-2690 MHz
		no mount	2300-2690 MHz

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14 Package outline

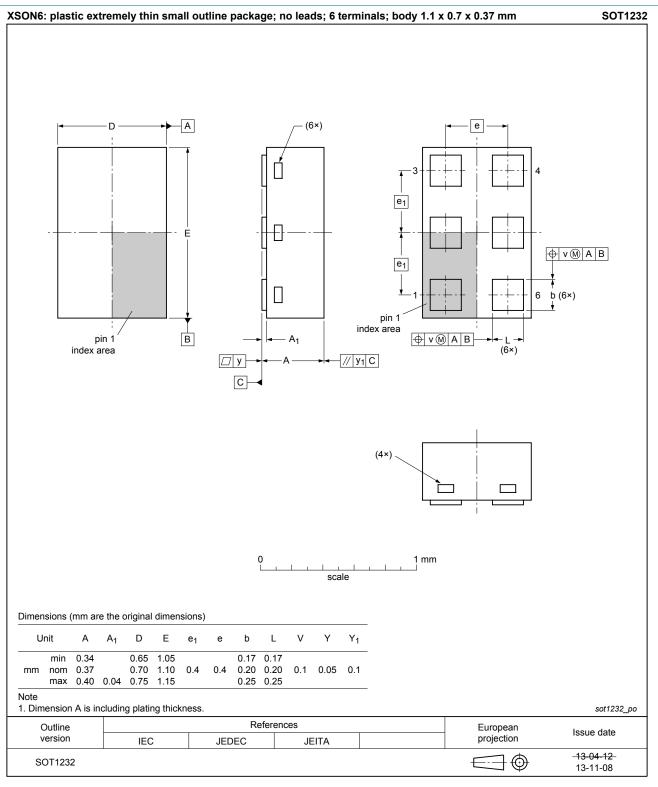


Figure 4. Package outline SOT1232 (XSON6)

15 Handling information



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices. Such precautions are described in the *ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A* or equivalent standards.

16 Abbreviations

Table 11. Abbreviations		
Acronym	Description	
ESD	electrostatic discharge	
HBM	human body model	
MMIC	monolithic microwave-integrated circuit	
MSL	moisture sensitivity level	
MUF	molded underfill	
LTE	long-term evolution	
PCB	printed-circuit board	
SiGe:C	silicon germanium carbon	

17 Revision history

Table 12. Revision history					
Document ID	Release date	Data sheet status	Change notice	Supersedes	
LTE3401H v.3	20190628	Product data sheet	-	LTE3401H v.2.3	
modification	added chapter with Gain mode specifications for wideband frequency range to Table 8 1.8 V				
LTE3401H v.2.3	20190430	Product data sheet	-	LTE3401H v.2.2	
modification	 added application information for extra frequency range added output power values to the Limiting values table added power gain variation values when using the matching inductor of 2.7 nH 				
LTE3401H v.2.2	20181218	Product data sheet	-	LTE3401H v.2.1	
modification	added extra column for Orderable part number to Ordering information table, to prevent confusion				
LTE3401H v.2.1	20181023	Product data sheet	-	LTE3401H v.2	
modification	added orderable part number to Ordering information table				
LTE3401H v.2	20180810	Product data sheet	-	LTE3401H v.1	
modification	data sheet changed from company confidential to public				
LTE3401H v.1	20172811	Product data sheet	-	-	

LTE3401H Product data sheet

18 Legal information

18.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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[2] [3] The term 'short data sheet' is explained in section "Definitions".

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Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



Как с нами связаться

Телефон: 8 (812) 309 58 32 (многоканальный) **Факс:** 8 (812) 320-02-42 **Электронная почта:** <u>org@eplast1.ru</u> **Адрес:** 198099, г. Санкт-Петербург, ул. Калинина, дом 2, корпус 4, литера А.